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Appendices

APPENDIX A. The summary of all applied MATLAB function

This section provides a quick review of all MATLAB function applied in this research work. For more detail type *help command* at Command Window.

Function	Description
abs	Compute the absolute value.
butter	Butterworth digital and analog filter design.
conv	Convolution sum computation.
ecdf	Calculate the cumulative distribution function of data values.
fclose	Close file.
fft	Computes the discrete Fourier transform coefficients.
filter	Create the filtered data from the input data and the filter coefficients.
fix	Rounds towards zero.
fopen	Open file.
fprintf	Write formatted data to file.
fscanf	Read formatted data from file
ifft	Computes the inverse discrete Fourier transforms coefficients.
imag	Determine the imaginary part of complex number.
max	Determine the largest element of a vector.
mean	Determine average or mean data values.
min	Determine the smallest element of a vector.
plot	Generate linear 2-dimension plot.
psd	Power spectral estimation via Welch's method.
rand	Generated pseudorandom number that is uniformly distribution over
	0,1.
real	Determines the real part of complex number.
serial	Construct serial port object.
set	Set object properties.
std	Determine the standard deviation of data values.
tfe	Transfer function estimation from input and output of system.
zeros	Create array of zero.

APPENDIX B. The summary of an applied script files

This section provides a description and detail of MATLAB script files applied in this research work.

Function	Description	
comm	Establish communication between TDS 360 and computer.	
tdstmp	Setup the controlled parameters of TDS 360.	
tdsver	Get amplitude multiplies and offset parameter.	
tdsdaq	Acquire data from TDS 360.	
tdsacc	Acquire a set of data from TDS 360.	
commclose	Close communication between TDS 360 and computer.	
noise	Generate random number from arbitrary cumulative distribution	
	function	
events	Generate time interval.	
signal_sim	Generate preamplifier output signal.	
cfilter	Calculate digital filter from an arbitrary frequency response.	

1. [out,tds_comm]=comm

tds_comm = serial('COM1');

set(tds_comm,'BaudRate',9600);

set(tds_comm,'InputBufferSize',2014);

set(tds_comm,'Timeout',2);

set(tds_comm,'Terminator','CR');

fopen(tds_comm);

fprintf(tds_comm,'*IDN?')

```
out= fscanf(tds_comm);
```

2. tdstmp(tds_comm)

%Turn off the header from query responses.

cmd=['HEADER OFF' char(13)]

fprintf(tds_comm,cmd)

%Set up the data source to be channel 1.

cmd=['DATA:SOURCE CH1' char(13)]

```
fprintf(tds_comm,cmd)
%Set up the data encodeing to be ribinary and data width to 1.
cmd=['DATA:ENCDG RIBINARY;WIDTH 1' char(13)]
fprintf(tds_comm,cmd)
%Set up the record length, which start from 1 stop at 1000
cmd=['HORIZONTAL:RECORDLENGTH 1000' char(13)]
fprintf(tds_comm,cmd)
%Start at 1
cmd=['DATA:START 1' char(13)]
fprintf(tds_comm,char(13))
%Stop at 1000
cmd=['DATA:STOP 1000' char(13)]
fprintf(tds_comm,cmd)
cmd=['HEADER OFF' char(13)]
fprintf(tds_comm,cmd)
3. [yoff,ymult]=tdsver(tds_comm)
%fprintf(tds_comm,'HEADER OFF')
cmd=['WFMPRE:CH1:YOFF?' char(13)];
fprintf(tds_comm,cmd)
yoff=fscanf(tds_comm);
fprintf(tds_comm,'HEADER OFF')
%for i=1:200000
%end
cmd=['WFMPRE:CH1:YMULT?' char(13)];
fprintf(tds_comm,cmd)
ymult=fscanf(tds_comm);
4. [sample]=tdsdaq(tds_comm,ymult,yoff)
[yoff,ymult]=ptdsver(tds_comm)
sample=[];
for i=1:10
[volt,wave]=ptdsacc(tds_comm,ymult,yoff);
```

```
sample=[sample;wave];
```

```
i
```

```
end
```

5. [volt,wave]=tdsacc(tds_comm,ymult,yoff) fprintf(tds_comm,'ACQUIRE:STATE RUN') %Wait for the scopr to acquire data for i=1:40000 end %Send scope curve query to get waveform data fprintf(tds_comm,'CURVE?') %Read data waveform %Wait for the scopr to acquire data %for i=1:100000 %end %volt = fscanf(tds_comm); volt=fread(tds_comm,2014,'uint8'); %Turn off the header from query responses. fprintf(tds_comm,'HEADER OFF') volt=volt(7:1007);%volt=volt(2:1000); for i=1:1000 %if volt(1+i*2)>127 if volt(1)>127 volt(i)=volt(i)-256; end end for i=1:1000 %wave(1+i)=volt(1+i*2)*256+volt(2+i*2)-sscanf(yoff,'%f'); wave(i)=volt(i)-sscanf(yoff,'%f'); end wave=wave*sscanf(ymult,'%f');

```
6. commclose(tds_comm)
fclose(tds_comm)
delete(tds_comm)
clear tds_comm
7. [sim]=noise(f,x)
%Generate random number
rnd=rand(1,1);
```

id=1;

```
while f(id) < rnd
```

id=id+1;

end

```
id=id-1;
```

```
%id=16
```

```
if id==24
```

```
sim=x(24);
```

else

```
dsim=(rnd-f(id))*(x(id+1)-x(id))/(f(id+1)-f(id));
```

```
%dsim=0;
```

```
sim=x(id)+dsim;
```

end

8. [event,count]=events(lambda,preset_time)

% This function returns time series of disintegration.

```
% 'event' is time series.
```

% 'count' is number of photons

```
% 't' is time distribution
```

a=0;

c=1;

```
while a<preset_time
```

```
t(c)=photon_gen(lambda);
```

```
% loop unit! reach preset_time
```

```
a=a+t(c);
```

```
% counting
```

```
c=c+1;
```

end

```
v=size(t);
```

```
count=v(2);
```

```
N=ones(1,count+1);
```

```
% stem(t,N)
```

% t=t';

event(1)=0;

```
for i=1:count
```

```
event(i+1)=event(i)+t(i);
```

end

count=count+1;

9. [v,t_sim,event,count]=signal_sim(a,lambda,preset_time,resol)

```
% event is time serie driven from events.m
```

```
% a is amplitude
```

```
[event,count]=events(lambda,preset_time);
```

```
% Time digitizer resolution is 1e-8
```

```
% resol=1e-8;
```

b=1;

```
s=size(event);
```

```
v=zeros(fix(preset_time/reso!)+1,1);
```

```
t_sim=zeros(fix(preset_time/resol)+1,1);
```

```
for t=0:resol:preset_time
```

```
for i=1:1:s(2)
```

```
if t>event(i)
```

```
v(b)=v(b)+a*exp((t-event(i))/-50e-6);
```

```
end
```

```
end
```

÷

t_sim(b)=t;

b=b+1;

end

10. [ht]=cfilter(h)

% h is frequency response

a=size(h);

na=a(1);

t=zeros(na,1);

% Kernel length

% old value 26/4/2004 M=100;

%M=5000;

M=1000

% Shift filter kernel length

%for i=1:a

% j=i+M/2;

```
% if j>a
```

```
% j=j-a-1
```

% end

```
% t(j)=h(i);
```

%end

%TEMPLATE

```
%b(1:M/2)=a(na-M/2+1:na)
```

```
%b(1+M/2:na)=a(1:na-M/2)
```

```
t(1:M/2)=h(na-M/2+1:na);
```

```
t(1+M/2:na)=h(1:na-M/2);
```

% Truncate and window the signal

```
for i=1:a
```

```
if i<= M
```

% Hamming windows

```
%t(i)=t(i)*(0.54-00.46*cos(2*pi*i/M));
```

% Blackman

```
t(i)=t(i)*(0.42-0.5*cos(2*pi*i/M)+0.08*cos(4*pi*i/M));
```

end

Specifications

INPUTS

INPUT – Accepts positive or negative pulses from an associated preamplifier; amplitude: ± 10 V divided by the selected gain for linear response; ± 12 V maximum: rise time: less than SHAPING time constant; decay time constant; 40 µs to ∞ for 0.5, 1, 2, 4 and 8 µs shaping time constants, 100 µs to ∞ for 12 µs shaping time constant; $Z_{\mu\nu} \approx 1$ kΩ; front and rear panel BNC connectors.

OUTPUTS

UNIPOLAR OUTPUT – Provides positive linear active-filtered near-Gaussian shaped pulses; amplitude linear to +10 V. 12 V max.; dc restored; output dc level factory calibrated to 0±5 mV. front panel $Z_{ad} \leq 1 \Omega$ or $\approx 93 \Omega$, internally selectable; rear panel $Z_{ad} \approx 93 \Omega$; short circuit protected; prompt or delayed 2 µs with option 2022-2 or 4 µs with option 2022-4; front and rear panel BNC connectors.

BIPOLAR OUTPUT – Provides prompt positive lobe leading linear active-filtered bipolar-shaped pulses; amplitude linear to =10 V. 12 V max., negative lobe is approximately 70% of positive lobe; dc coupled; output dc level=25 mV; front panel



APPENDIX C.2 XR-100T-CdTe radiation detector specification



SPECIFICATIONS MODEL XR-100T-CdTe X-RAY and GAMMA RAY DETECTOR

GENERAL **Detector** Type Detector Size: Detector Thickness Energy Resolution @ 122 keV, ⁵⁷Co Dark Counts

<5 x 10⁻³ counts/sec @ 10 keV < E < 1 MeV Detector Window: Be, 10 mil thick (250 µm) Preamplifier Amptek Model A250, with **Current Divider Feedback** 3.75 x 1.75 x 1.13 in

CdTe-Diode

1 mm

 $3 \times 3 \text{ mm} (9 \text{ mm}^2)$

 $(9.5 \times 4.4 \times 2.9 \text{ cm})$

4.4 ounces (125 g)

± 8 Volts @ 25 mA

+ 400 Volts @ 1 µA

20 mV test pulse ~ 30 keV

Current = 0.7 A maximum Voltage = 2.1 Volt maximum

Less than 1 Watt

<1.2 keV FWHM, typical

Case Weight: Total Power:

Case Size:

INPUTS Test Input: Preamp Power: Detector Power: Cooler Power

OUTPUTS

1) Preamplifier Sensitivity: 0.82 mV/keV Polarity: Negative Signal Out $(1 k\Omega max. load)$ 2) Temperature Monitor Sensitivity 1 µA corresponds to 1 °K CONNECTIONS

Preamp Output: Test Input: Other connections BNC coaxial connector BNC coaxial connector 6-Pin, LEMO connector with 5 ft cable

OPTIONS

- Other detector sizes (5 x 5 x 1 mm³) are available on special orders

- Other Be window thicknesses are available

- Components for vacuum applications.

- Collimator kit for high flux applications

- See also XR-100CR specifications using Si-PIN for detection of low energy X-Rays with high resolution (186 eV FWHM @ 5.9 keV, 55Fe).

6-PIN LEMO CONNECTOR ON THE XR-100T-CdTe

Pin 1: +8 Volt temperature monitor power

+ H.V. detector bias, +400 Volt max Pin 2

- Pin 3: -8 Volt preamp power
- Pin 4 +8 Volt preamp power
- Pin 5: Cooler power return

Pin 6: Cooler power (0 to +2.1 Volt @ 0.7 A max.)

CASE: Ground and shield

MODEL PX2T **POWER SUPPLY + SHAPING AMPLIFIER** GENERAL 6 X 6 X 3.5 inches (15.3 X 15.3 X 8.9 cm) Size

Weight 2.5 lbs (1.15 kg)

Input AC power to the PX2T is provided through a Standard IEC 320 plug (110/250 VAC, 50/60 Hz). See Figure 3.

The four (4) DC Voltages needed to operate the XR-100T-CdTe are supplied through a female 9-Pin D-Connector on the PX2T. The Pin list to this connector is given below. The multiconductor cable which connects the PX2T to the XR-100T-CdTe is provided with the system.

9-PIN D-CONNECTOR ON THE PX2T-CZT

Pin 1: +8 Volt preamp power

Pin 2: -8 Volt preamp power

Pin 3: 0 to +3 Volt cooler power @ 0.7 A max.

Pin 4: +8 Volt temperature monitor power

Pin 5: + H.V. detector bias, +400 Volt max.

- Pin 6: Ground and case
- Pin 7: Cooler power return

Pin 8: Ground and case

Pin 9: Ground and case

PX2T SHAPING AMPLIFIER

Polarity:	Positive Unipolar
Shaping Time:	3 μs
Pulse Width:	7.2 µs FWHM_See Figure 4
Shaping Type:	7 pole "Triangular" with Base Line Restoration, Pileup Rejection, and Rise Time Discrimination (RTD).
Sensitivity with	

XR-100T-CdTe 6 to 60 mV/keV Output Range +6.0 Volts into 500 Ω load Output Impedance: 50 Ω

The output pulse produced by the PX2T Shaping Amplifier is optimum for most applications using cooled CdTe detectors, and can be connected directly to the input of a Multichannel Analyzer (MCA). If different shaping time constants or gains are needed, an external NIM type shaping amplifier with base line restoration can be used

PX2T SIGNAL CONNECTIONS

input from XR-100T-CdTe:	Front panel BNC
Output to MCA:	Front panel BNC
Pileup Rejection (PU):	Rear panel BNC, Positive TTL For the duration of this output gate, any detected pulse must be rejected by the MCA.
Input Count Rate (ICR):	Rear panel BNC, Positive TTL $<2 \mu s$ When connected to a counter, the ICR countrate corresponds to the total number of X-Rays events that strike the detector

Biography

Mr.Hudsaleark Neamintara was born on January 20,1966 in Bangkok, Thailand. He got his Bachelor Degree from the Department of Radiological Technology, Faculty of Associated Medical Sciences, Chiangmai university in 1988 and Master degree from Department of Nuclear Technology, Faculty of engineering, Chulalongkorn university in 1993. At present he serves as Lecturer in the field of X-ray Diagnostic Apparatus, Department of Radiological Technology, Faculty of Associated Medical Sciences, Chiangmai University. In May 2000, he was awarded a grant from Chiangmai University to further his study for the Doctoral Degree at the Department of Nuclear Technology, Faculty of Engineering, Chulalongkorn University.

